

**Search Notes**

Application/Control No.

10/665,317

Examiner

Stephanie Smith

Applicant(s)/Patent under  
Reexamination

SNELL ET AL.

Art Unit

3762

**SEARCHED**

Class	Subclass	Date	Examiner
607	17, 30- 32,59- 60,62	3/2/2006	SRS

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched using keywords such as electrogram, ensemble averag\$3, histogram, graph, count, amplitude, time, acquire, adjust	3/2/2006	SRS
Searched using keywords such as modif\$4, alter, chang\$3	3/2/2006	SRS